

Notice of References Cited	Application/Control No. 09/889,687	Applicant(s)/Patent Under Reexamination DEKANY ET AL.	
	Examiner Devesh Khare	Art Unit 1623	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,538,117	03-2003	Wong et al.	536/18.5
	B	US-6,040,433	03-2000	Kahne et al.	536/4.1
	C	US-			
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	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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*	N	EP 578,112	01-1994	Europe	Yamada et al.	
	O					
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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